



Serial No. 10/662,567

PATENT  
Attorney Docket No. 20015/10003

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

~~DEMA~~ plicant : John Dennis CLARK  
U.S. Serial No. : 10/662,567  
Filed : 9/15/2003  
Title : METHODS AND APPARATUS FOR MONITORING AND CONDITIONING STRIP MATERIAL  
Art Unit : 3725  
Examiner : Daniel C. Crane

Mail Stop Amendment  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**SUMMARY OF EXAMINER INTERVIEW CONDUCTED ON APRIL 25, 2006**

Dear Sir:

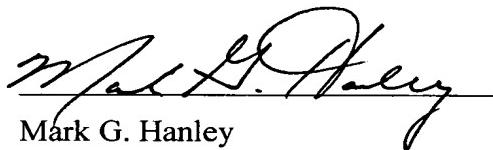
The applicant wishes to thank the examiner for granting the interview of April 25, 2006. During the interview, the examiner, the applicant's representative and attorney of record Mark G. Hanley, and law clerk Felipe Hernandez discussed independent claims 38, 46, 54, 72, 77, 92, 101, 109, and 113 in view of Jeuniaux et al. (U.S. 5,465,214). In particular, with respect to claims 38, 46, and 54, the attorney of record requested clarification of how the examiner contends that Jeuniaux et al. shows determining a difference between a first wave height of the material in a first one of the longitudinal zones and a second wave height of the material in a second one of the longitudinal zones. With respect to claims 72, 77, 92, 101, 109, and 113, the attorney of record requested clarification of how the examiner

contends that Jeuniaux et al. shows comparing first and second values. The attorney of record agreed to make remarks traversing the rejections in the response to the final official action, which was filed on May 3, 2006.

If there are any remaining matters that the examiner would like to discuss, the examiner is invited to contact the undersigned representative at the telephone number set forth below.

Respectfully submitted,

Dated: **May 9, 2006**



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